

<b>Notice of References Cited</b>	Application/Control No. 10/736,738		Applicant(s)/Patent Under Reexamination DAVIDSON ET AL.	
	Examiner CRYSTAL I. LEACH		Art Unit 3737	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,558,691 A	12-1985	Okada, Minoru	600/117
*	B	US-4,702,229 A	10-1987	Zobel, Jurgen	600/117
*	C	US-4,895,431 A	01-1990	Tsujiuchi et al.	359/29
*	D	US- H,000,999 H	12-1991	Merkel et al.	356/239.1
*	E	US-5,967,968 A	10-1999	Nishioka, Norman S.	600/117
*	F	US-6,478,732 B2	11-2002	Adachi, Rensuke	600/178
*	G	US-2003/0032863 A1	02-2003	Kazakevich, Yuri	600/173
*	H	US-2003/0167000 A1	09-2003	Mullick et al.	600/424
*	I	US-2004/0176684 A1	09-2004	Tabuchi et al.	600/424
*	J	US-2007/0073161 A1	03-2007	Davidson, Tal	600/476
*	K	US-2007/0060798 A1	03-2007	Krupnik et al.	600/300
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.